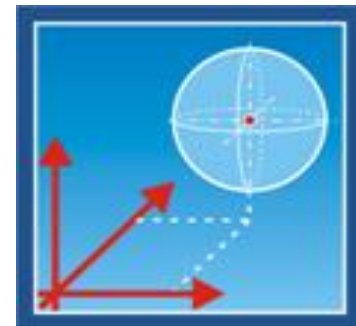
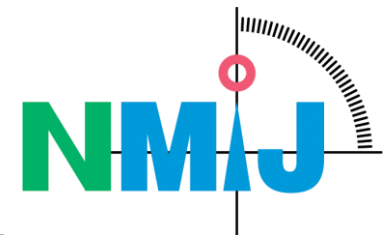


Coordinate metrology using computed tomography systems – an overview of PTB's activities with a focus to standardization

**Markus Bartscher, Osamu Sato*, Jens Illemann, Ulrich Neuschaefer-Rube,
Frank Härtig**

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Braunschweig and Berlin, Germany

* National Metrology Institute of Japan
National Institute of Advanced Industrial Science and Technology,
Tsukuba, Japan





1. Introduction

Standardization for dimensional CT

Recent development & open issues for CT

Material impact on measured lengths

2. Performance testing of CT systems

Length measuring error testing using a hole plate

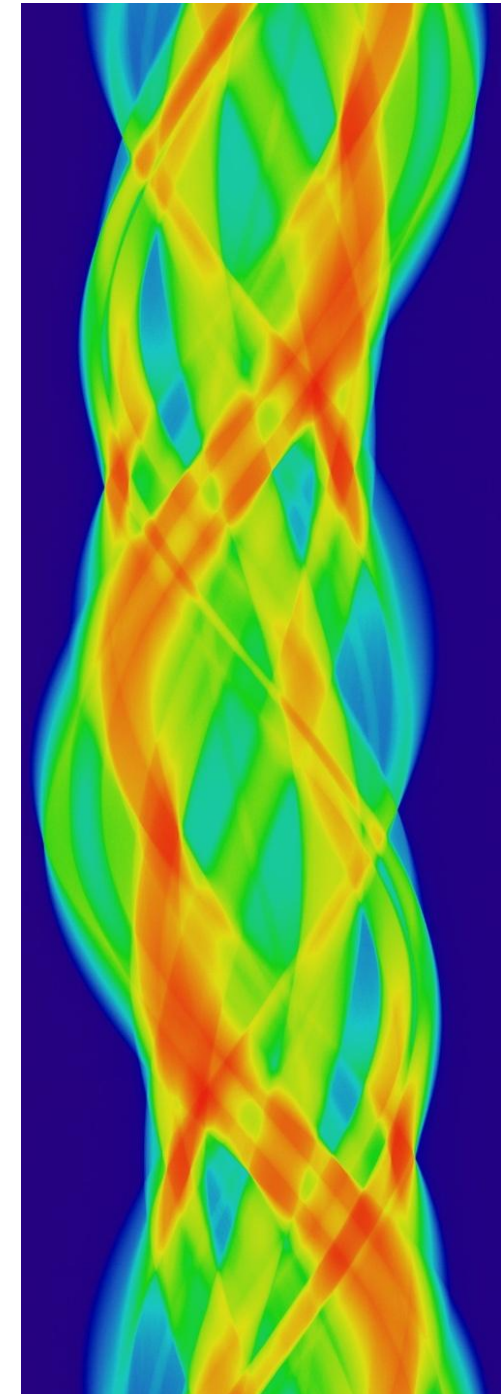
New hole plate design

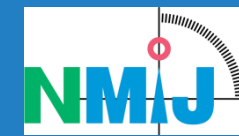
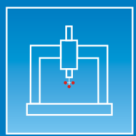
Probing error testing

Structural resolution for coordinate metrology

New approach to resolution testing

3. Summary





National standardization

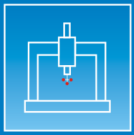
Germany: VDI/VDE 2630-1.3 (2011-12) on specifications (acceptance testing)

International standardization

ISO TC 213 WG 10: Preliminary working item CT has been defined
Task force objective: Create **ISO 10360-11 for CT**

Principles (written form is pending):

- 1) **CMS (former CMMs) shall be tested as *integrated systems***
(no component testing)
- 2) **Tests shall include the *dominant error behavior***
New classification for influence quantities (<5%, 5 % ... 15%, > 15%)
- 3) **Tests shall comprise *local and global performance characteristics***
Test of probing errors for size *PS* and form *PF*
Test of length measurement errors *E*



Open issues & recent developments for ISO work on CT:

Create comparable characteristics

Finalize test design & procedures

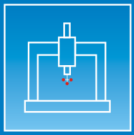
Include material influence in tests

Analyse behavior for uni- and bidirectional measurands (length measurements E)

Solve structural resolution testing issue for dimensional measurements

Focus of following presentation and discussion

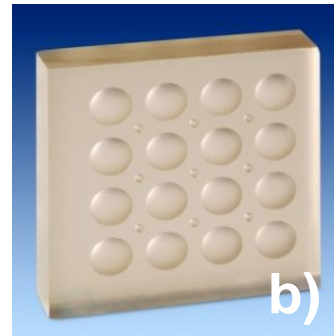
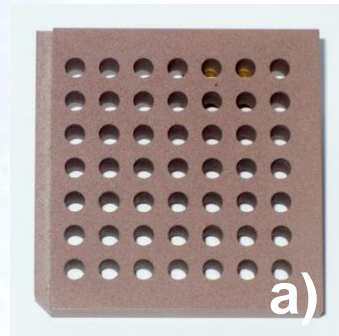




Length measurement error E testing

- MPE_{Em} including material influence; examples, implicit with internal features

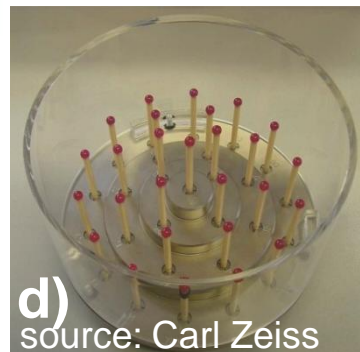
- a: hole plate
- b: “calotte” plate
- c: “calotte” cube



**Under discussion:
Test with hole plate
sufficient to show
material influence?**

- MPE_{EZ} negligible material influence

- d: multiple sphere standards (stylus or probe forest)
- e: stylus star



d)
source: Carl Zeiss



**Additional measure-
ments for material
influence testing
required
(e.g. step cylinder)**



Hole plate

featuring 4 primitive directions



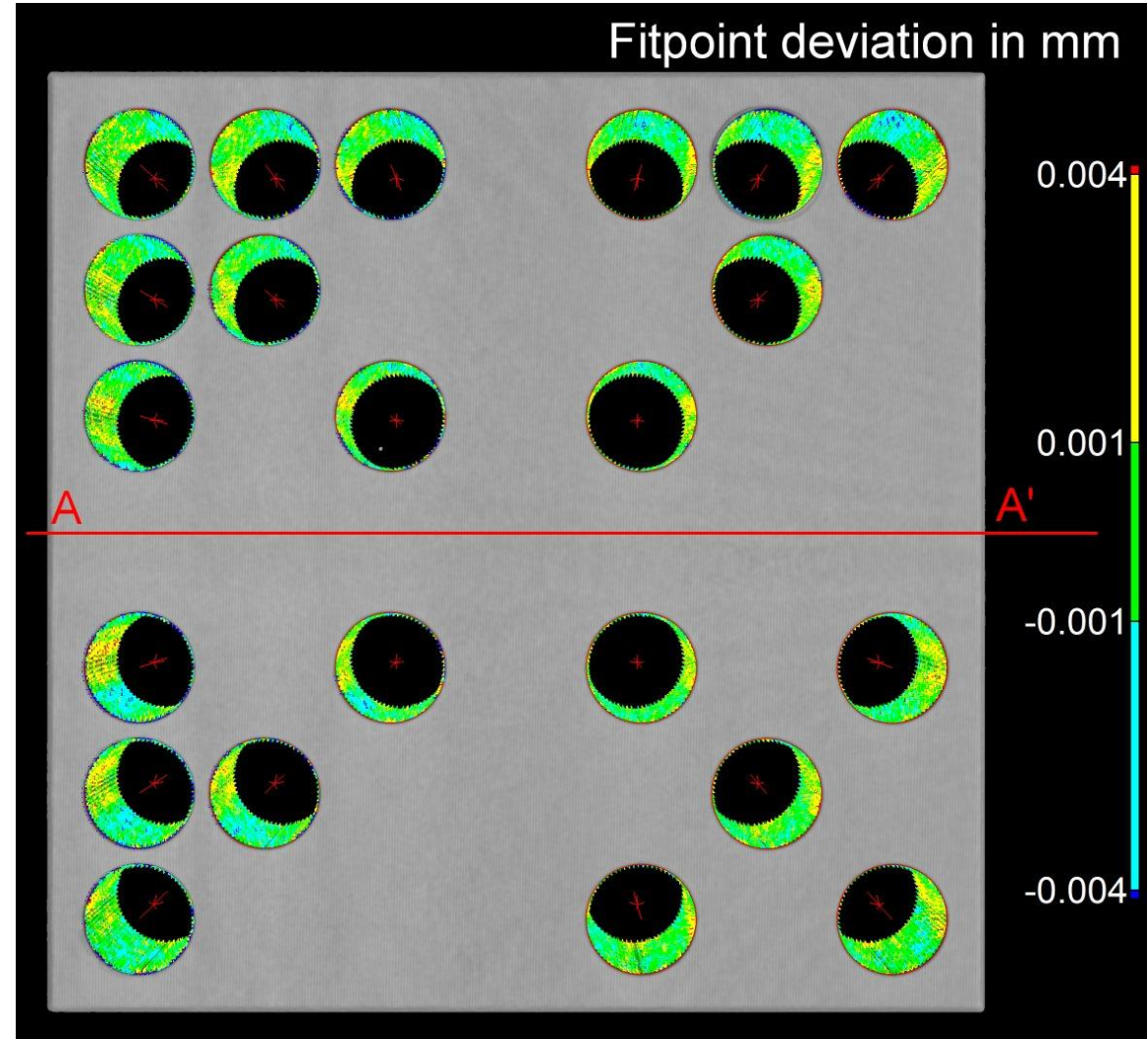
Standard courtesy of Werth Messtechnik, Germany

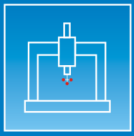
CT measurement (PTB CT system):

190 kV, 10.3 W, 0.3 mm Cu, 1640 projections

Magnification 4.0 – voxel size (50.0 μm)³

95% form dispersion values of individual cylinder 3.1 μm





Length measurement testing

Classical approach: [bidirectional test](#)

Now: [unidirectional test](#) becoming standard
(additional bidirectional statement feasible
either by measurement or correction)

(approach due to problems of optical sensors and
due to ongoing consideration of sensor and mover
separation)

Here:

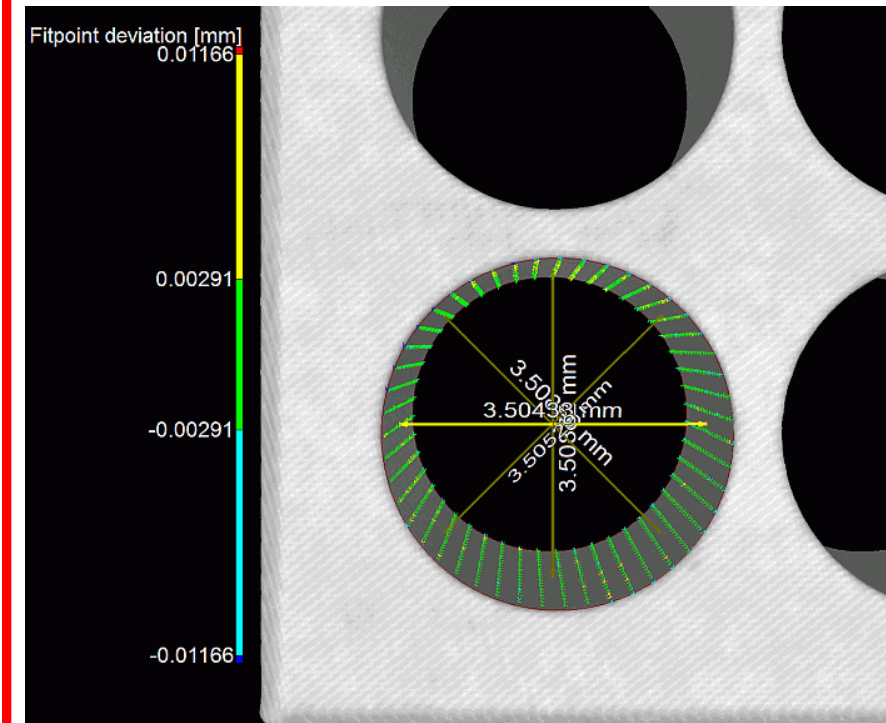
**Unidirectional length measurement errors
= Centre distance errors of cylinders**

**Bidirectional length measurement errors
= Centre distance errors of cylinders +
correction**

Conversion uni- to bidirectional
based on VDI/VDE 2630-1.3 and
ISO 10360-8:

*Add bidirectional measure to
unidirectional values
here:*

*Two-point diameter error of one
hole collinear to measurement line*





Test study using hole plate

$U = 190$ kV, $P = 10.3$ W, 0.3 mm Cu filter, 1640 projections

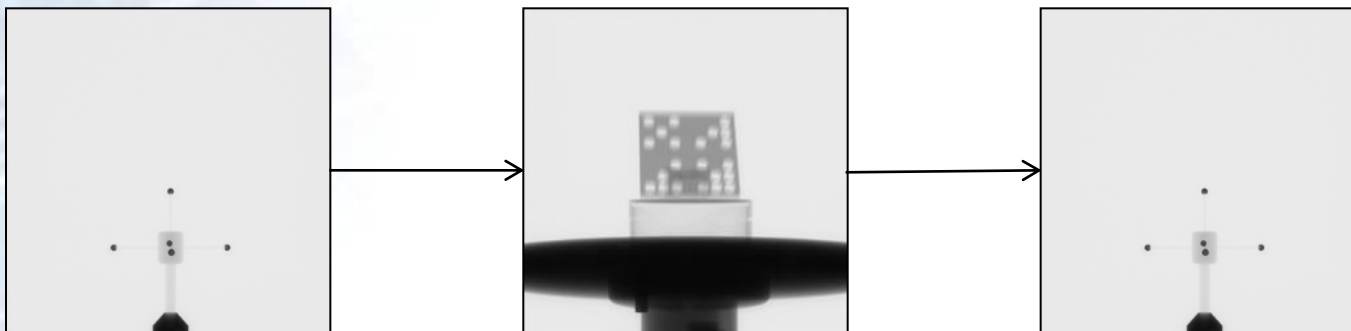
Magnification: 4.0 (voxel size: 50 μm), fast CT mode (1h 50min), tilted setup

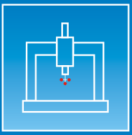
4 verified direction on plate (0° , 90° , 45° and 135°)

Reconstruction: w/o, with soft and mid beam hardening correction

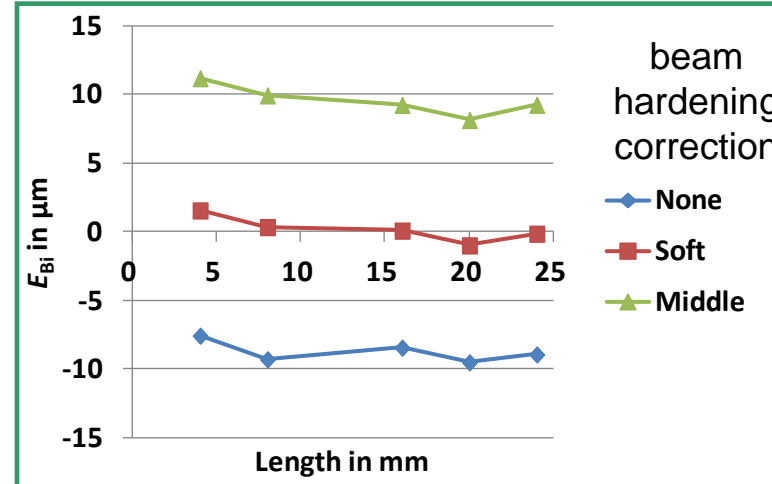
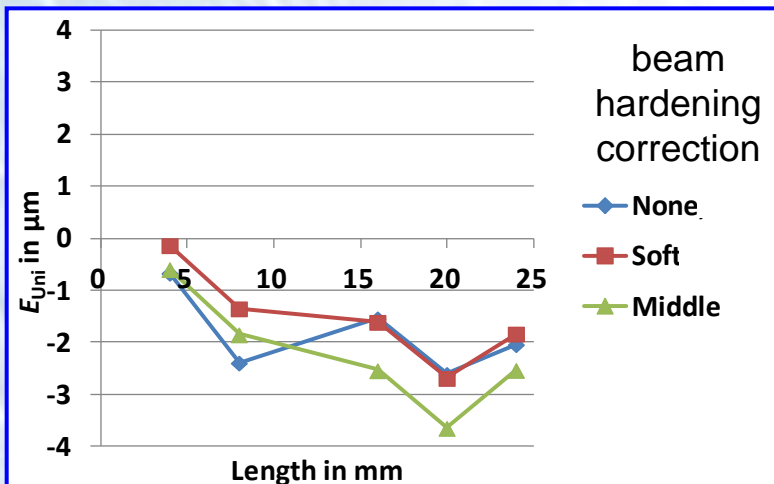
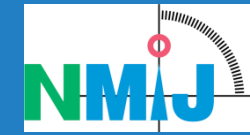
Quality assurance provisions:

- 1) Correct residual scaling error before hole plate test
- 2) Correct residual rotation axis tilt before hole plate test
- 3) Check drift of scaling – if present after hole plate test

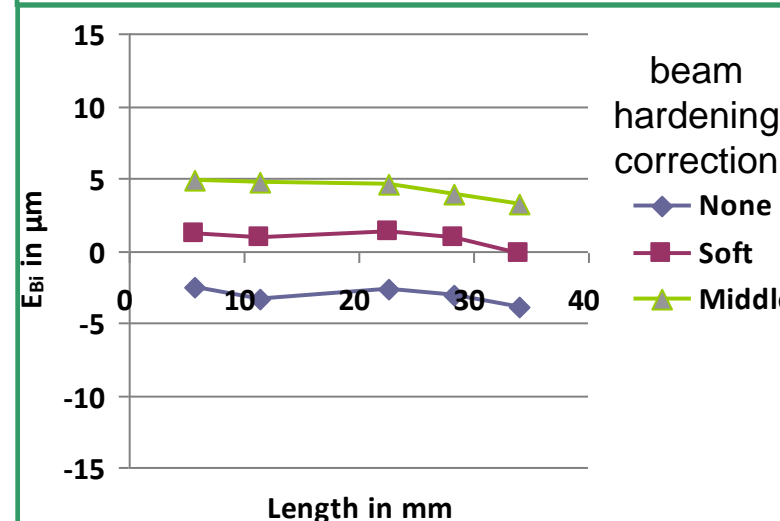
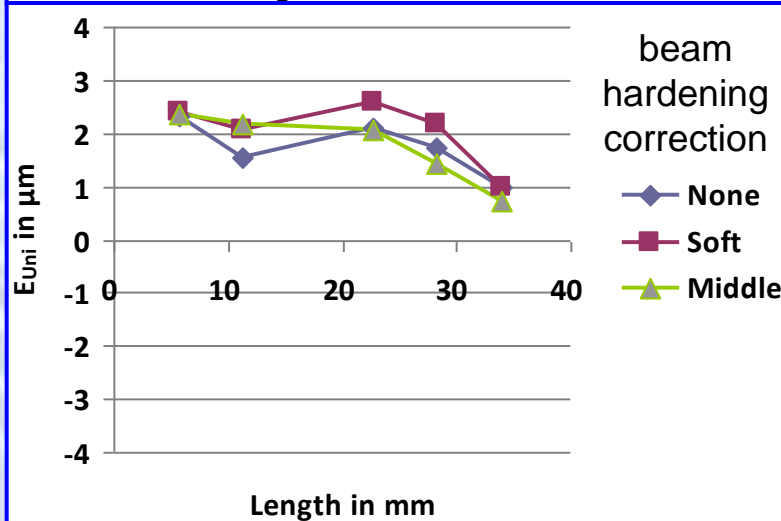




Length measurement error analysis



0° horizontal



-45° diagonal

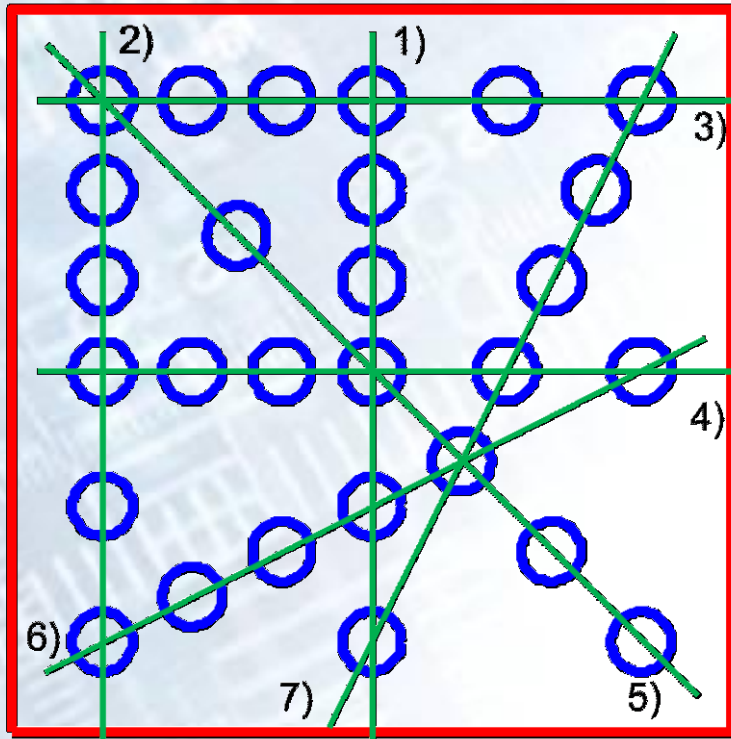
Unidirectional measurement
(centre-to-centre distance)

Bidirectional measurement
(centre-to-centre + 2 point diameter error)

Nearly no material impact for unidirectional lengths
Big material influence for bidirectional length measurements!



New design of hole plate with 28 holes



Advantage of new design:

7 lengths measured in one setting

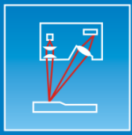
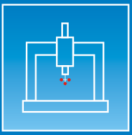
Size considerations for aluminum (low magnification case)

X-ray tube voltage in kV	Dimensions of square-shaped hole plate in mm			Material
	Side	Thickness	Diameter of holes	
90	18.0	3.0	1.5	Al
130	30.0	5.0	2.5	
225	48.0	8.0	4.0	
450	66.0	11.0	5.5	
600	77.0	13.0	6.0	

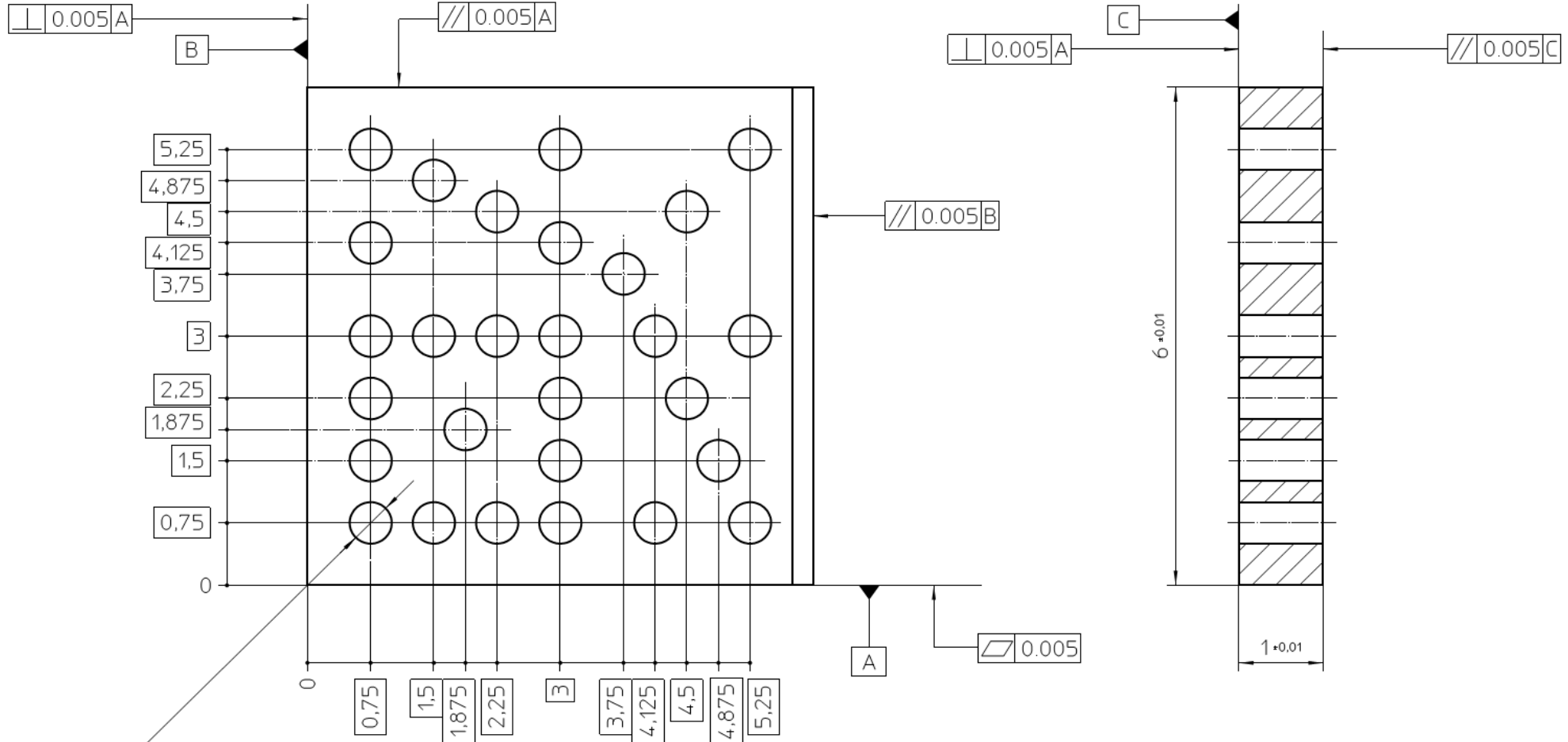
Size considerations for steel (high magnification case)

X-ray tube voltage in kV	Dimensions of square-shaped hole plate in mm			Material
	Side	Thickness	Diameter of holes	
90	6.0	1.0	0.5	Fe
130				
225				
450				ZrO ₂
600				WC





CAD sketch of steel hole plate

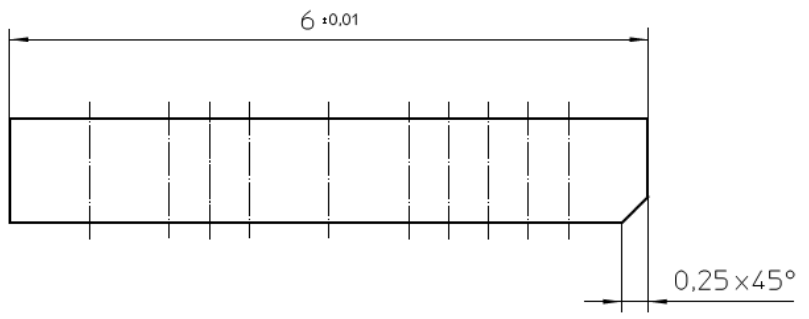


28x $\varnothing 0.5 \pm 0.005$

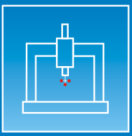
\varnothing	$\varnothing 0.005$	C	A	B
\perp	$\varnothing 0.001$	C		
∇	0.002			

∇ Ra 0.8

Size ISO 14405



Schutzvermerk nach ISO 16016 beachten	Fertigungskordinator		lesbare Blockschrift - Unterschrift		Datum
			Zu. Abw. DIN ISO 2768-mK	Maßstab 20:1	Gewicht
			Oberfläche ISO 1302	Werkstoff, Halbzeug X5CrNi18-10	
			Werkstückkanten ISO 13715	Benennung	
		Grundlochüberhang e1 DIN 76	2013 Datum Name		
		Bearb. 28.05. G.Kutilek	Hole plate (small)		
		Gepr.	NUR MIT ORIGINALUNTERSCHRIFT GÜLTIG		
			PTB		Artikelnummer
					Blatt 1
Zust.	Änderung	Datum	Name	5.5 - Wissenschaftlicher Gerätebau	v. 1 Bl.
				Zerchn.-Nr.	Version

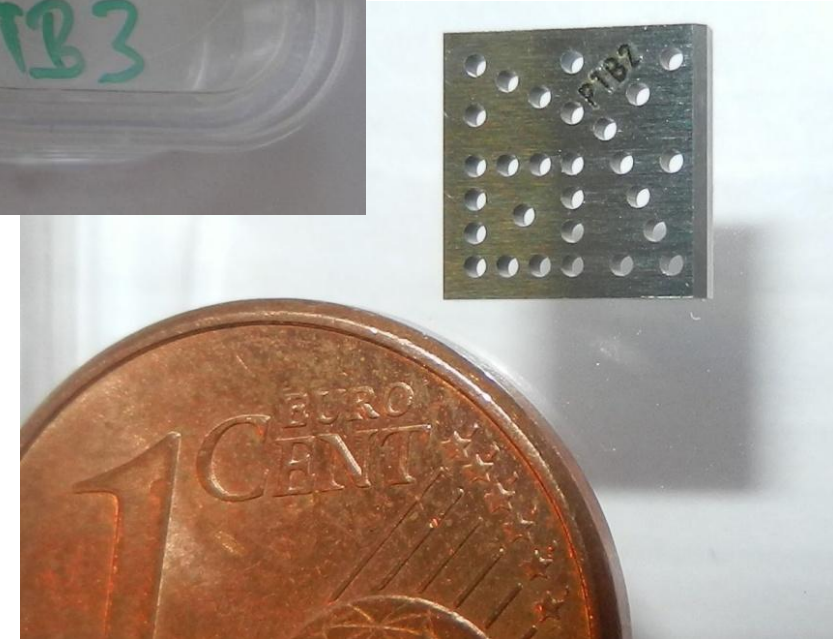


Manufactured steel hole plates



Price for three specimen (industrial manufacturing):
2400 € incl. VAT

Currently ISO test study on material impact on dimensional CT started (results due Feb. 2014). Hole plates are in use here



Schutzvermerk nach ISO 16016 beachten	Fertigungskordinator		lesbare Blockschrift - Unterschrift		Datum
			Zu. Abw. DIN ISO 2768-mK	Maßstab 20:1	Gewicht
			Oberfläche ISO 1302	Werkstoff, Halbzeug X5CrNi18-10	
			Werkstückkanten ISO 13715	Benennung	
			Grundlochüberhang e1 DIN 76	Hole plate (small)	
		2013	Datum	Name	
		Bearb.	28.05.	G.Kutilek	
		Gepr.			
	NUR MIT ORIGINALUNTERSCHRIFT GÜLTIG				
			PTB		Artikelnummer
Zust.	Änderung	Datum	Name	5.5 - Wissenschaftlicher Gerätebau	
				Zechn.-Nr.	
				Version	
				Blatt 1 v. 1 Bl.	



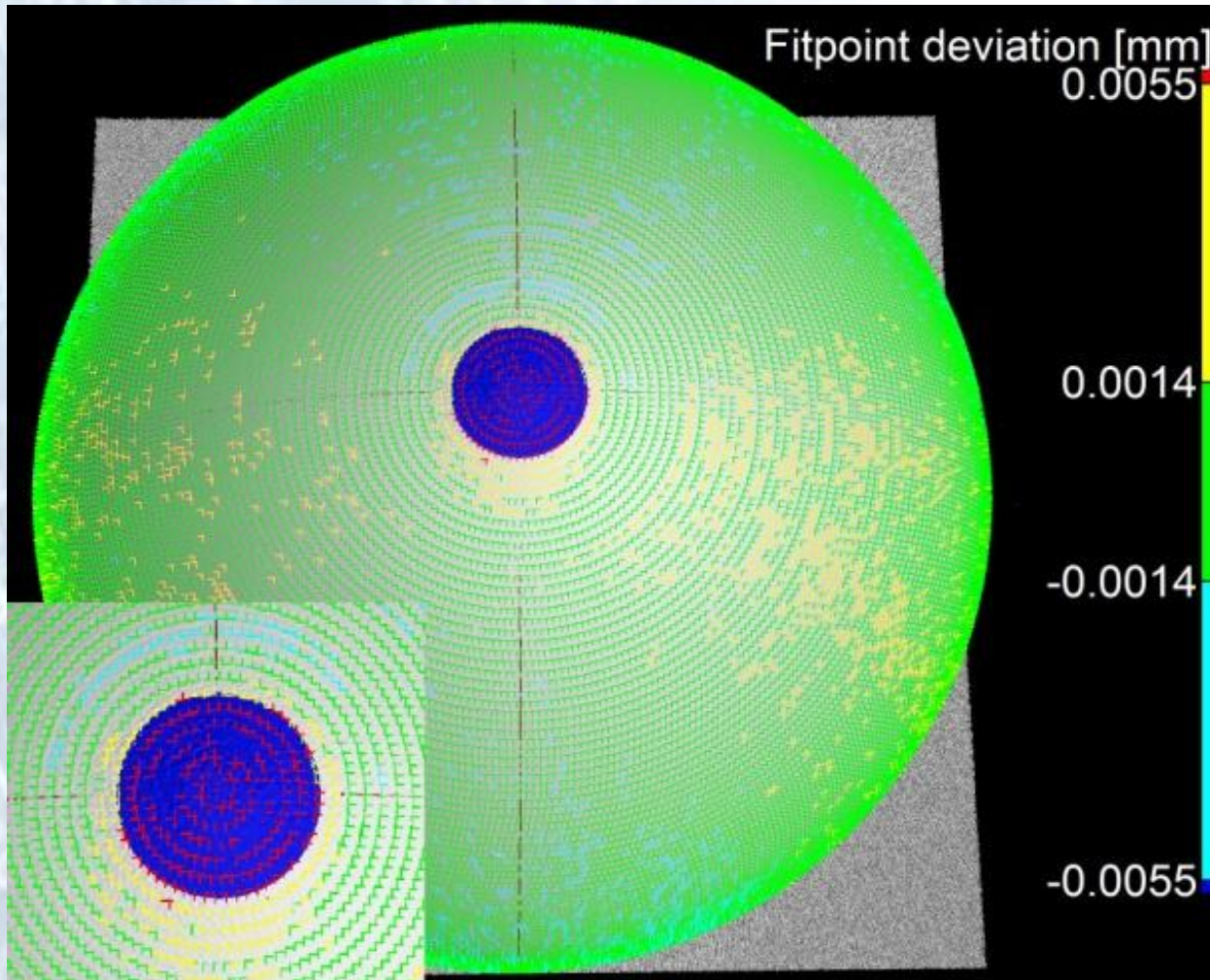
8 mm ruby test sphere measurement
off central plane (90kV, 3.6W, no filter,
voxel size [8.2 μm]³)

→ Artefact at one pole region!
(further away from centre)

Size is e.g. 0.6% of hemisphere area

→ $P_{\text{Form.Sph.D95\%}}$ probing dispersion error
excludes this effect!

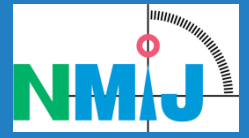
Test criteria shall be adapted as this
effect is realistic also for real's life parts
and shall be included in dimensional
CT testing



↑ Magnified pole region

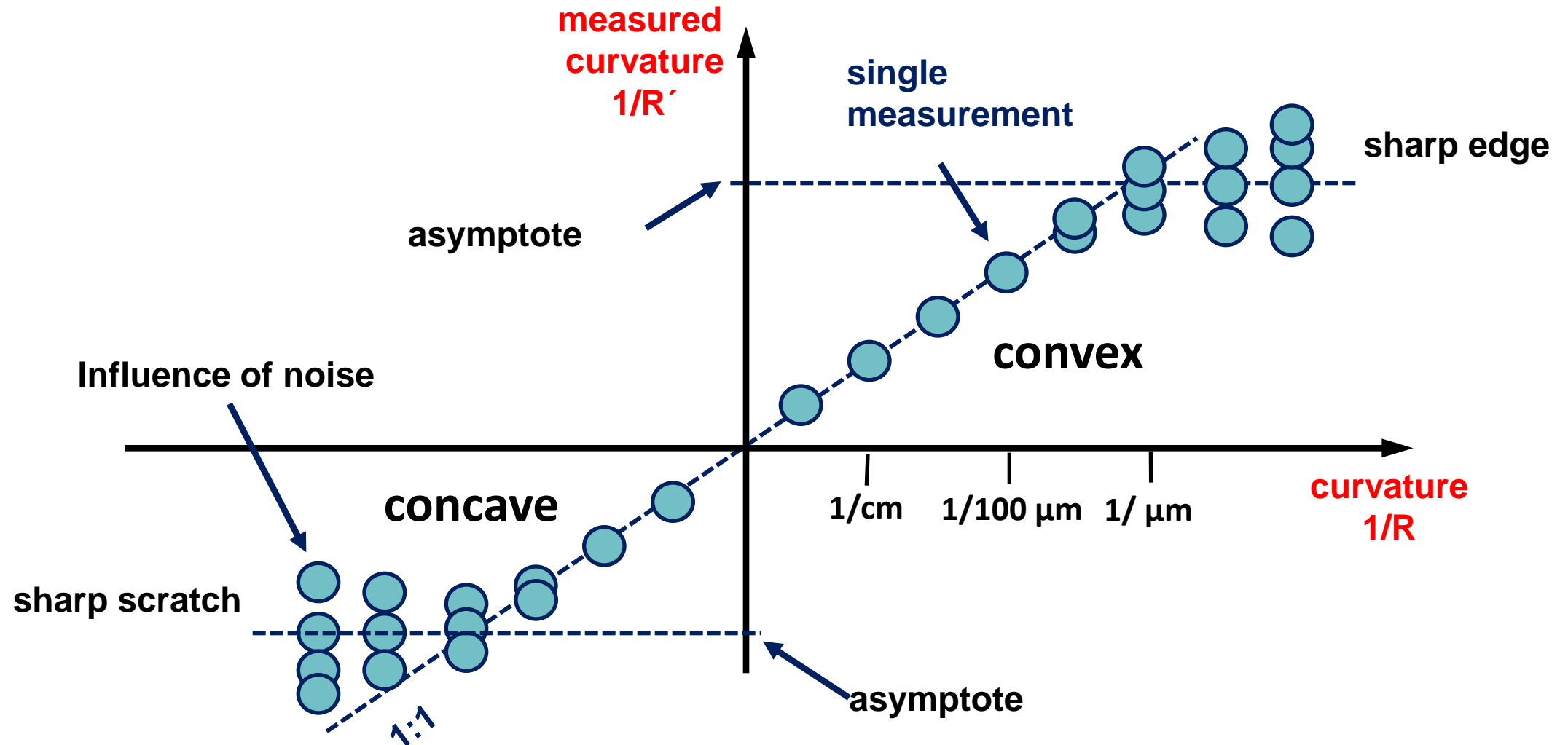


Structural resolution



Property of CMS described by curvature transfer

Presentation for one direction:





Approach



The sensor system locally **convolves** the coordinate values in tangential direction. The edge will be flattened

The kernel is assumed a **Gaussian with a full width S** . This size **defines the structural resolution**

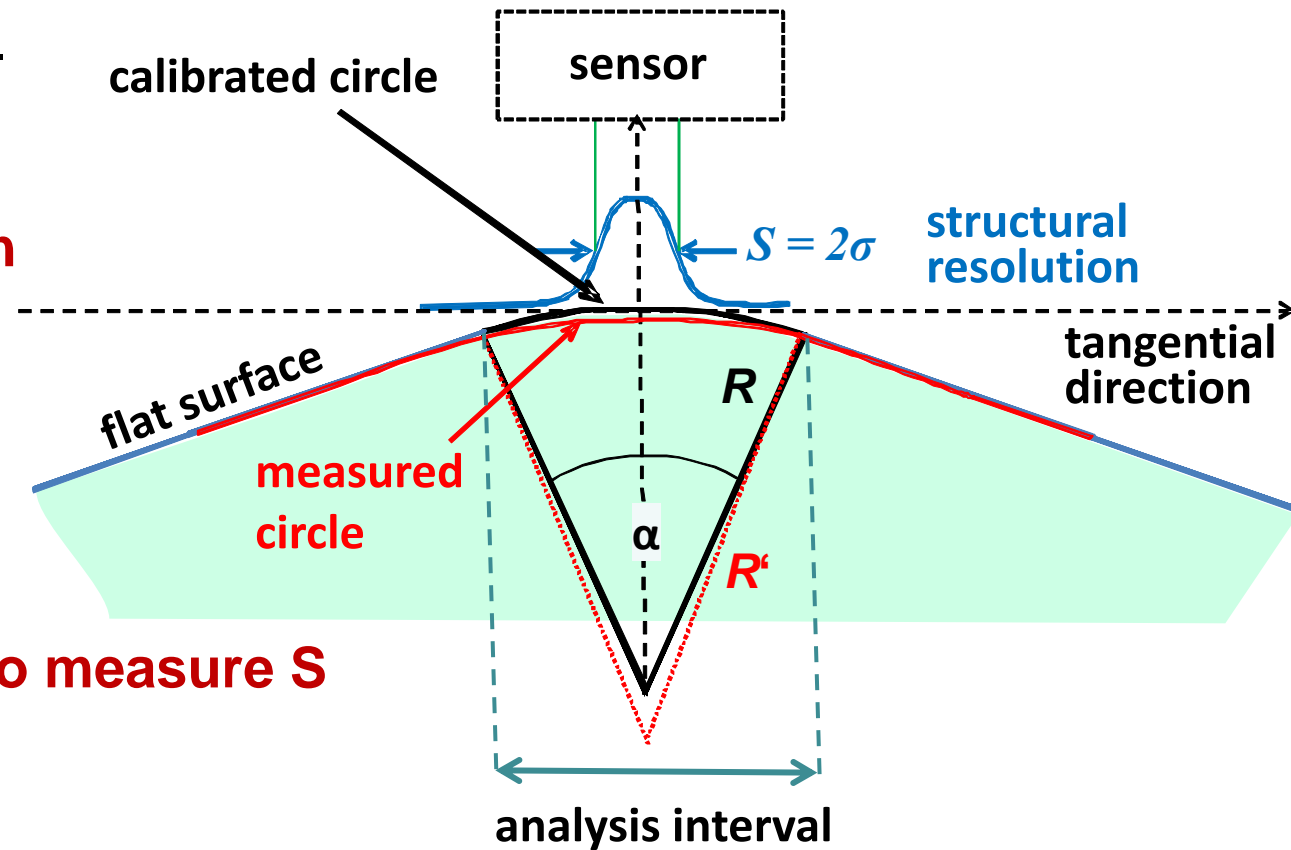
The **ratio of measured radius** of the arc **and calibrated value enables to measure S**

The radii are determined by a **least-squares** method.

Consider only data in the **region of interest** interval

$$[-\sin(\alpha/2) \cdot R, +\sin(\alpha/2) \cdot R]$$

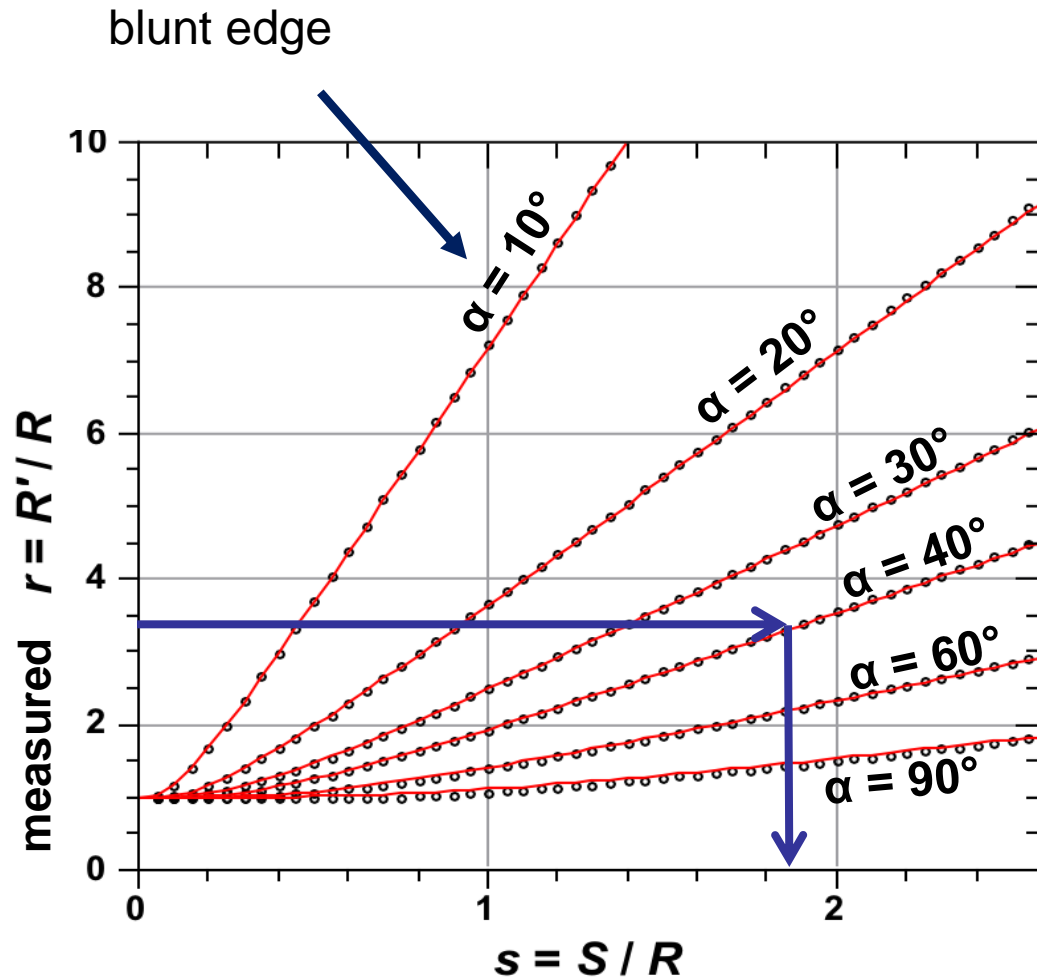
using the known **arc opening angle** and known **radius**





Structural resolution S deduced from ratio of measured radius R' and calibrated radius R

Result of simulations:

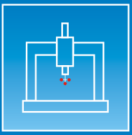


Analytic description (implicit equation!)

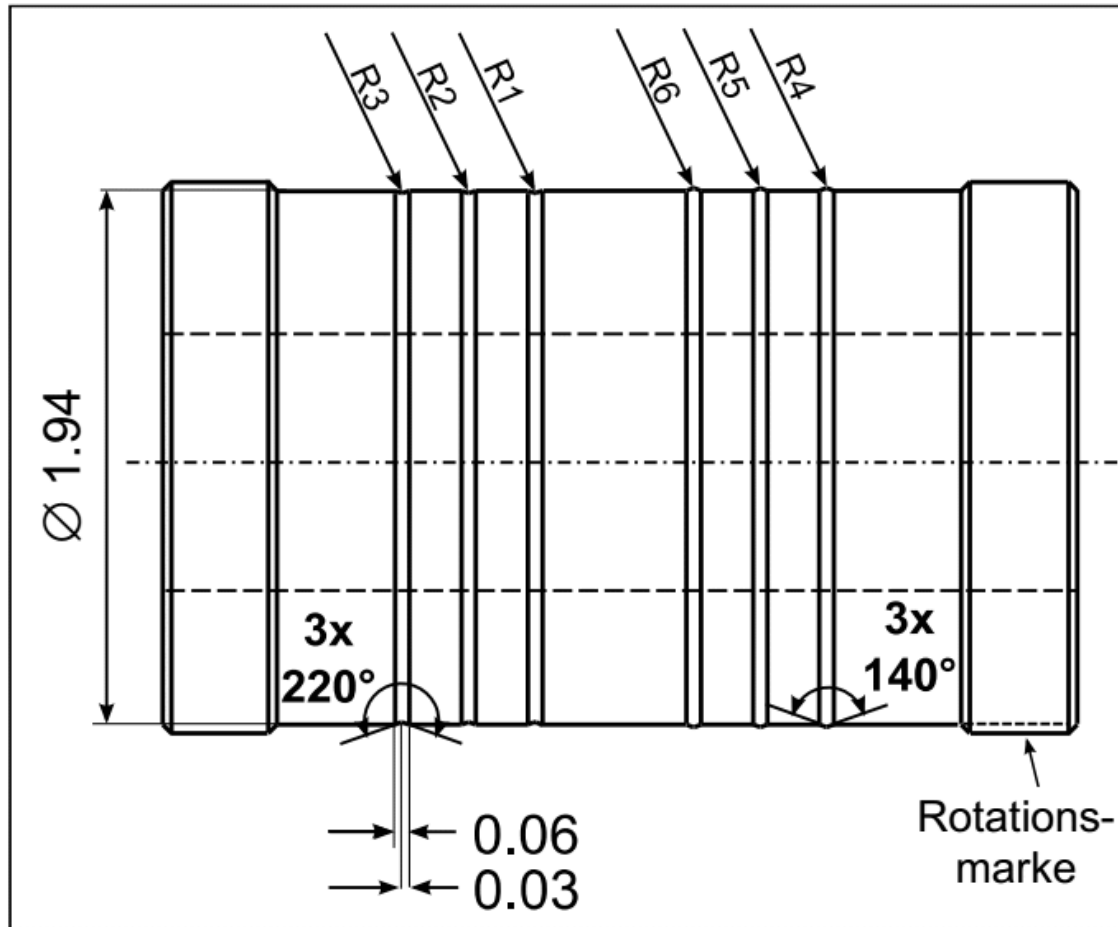
$$r = \frac{R'}{R} = \frac{1}{\operatorname{erf}\left(\frac{\tan(\alpha/2)}{(S/R)/\sqrt{2}}\right)}$$

Parametric approximation (also implicit)

$$r \cong 1 + l \cdot e^{-1,06/l}, \quad l = \frac{0,628 \cdot (S/R)}{\tan(\alpha/2)}$$



Reference standard

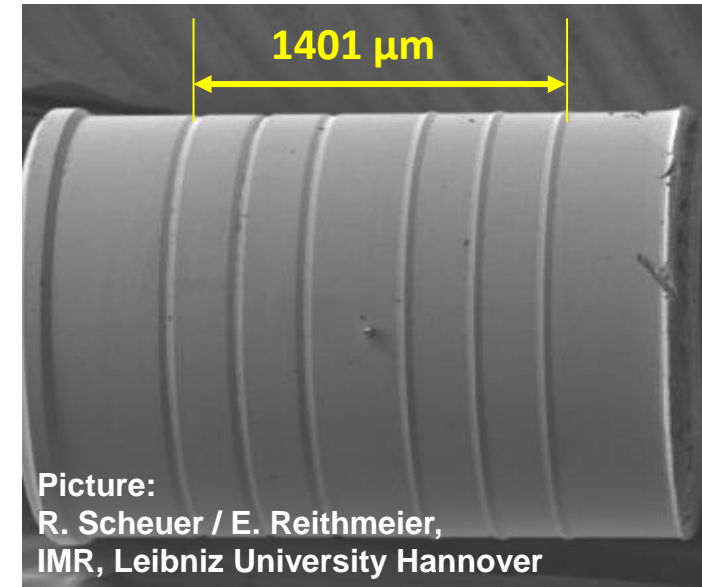


Selected radii: 1 μm – 5 μm (nominal)

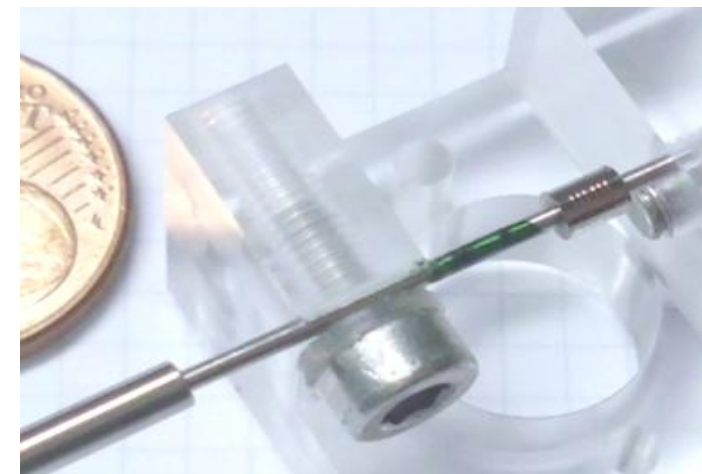
Manufacturing:

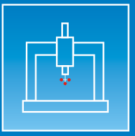
Diamond turned amorphous Ni-P on copper
(PTB scientific instrumentation department)

REM images of reference standard



Mounted reference standard



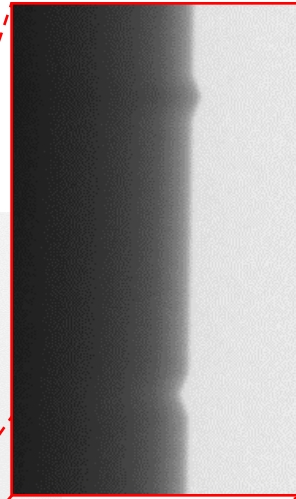
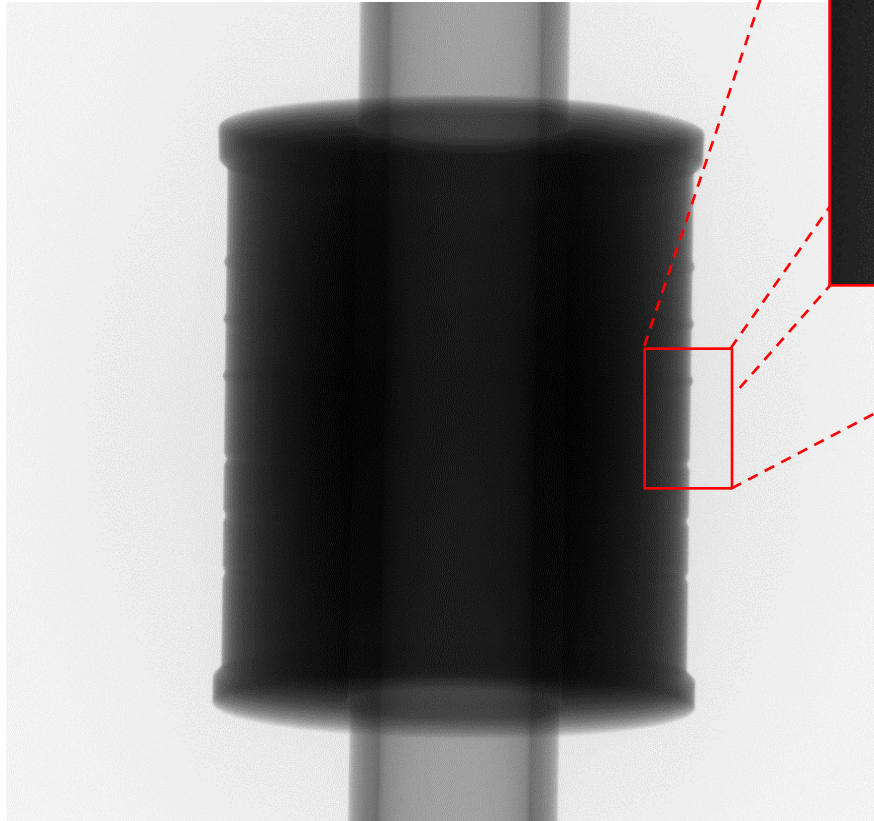
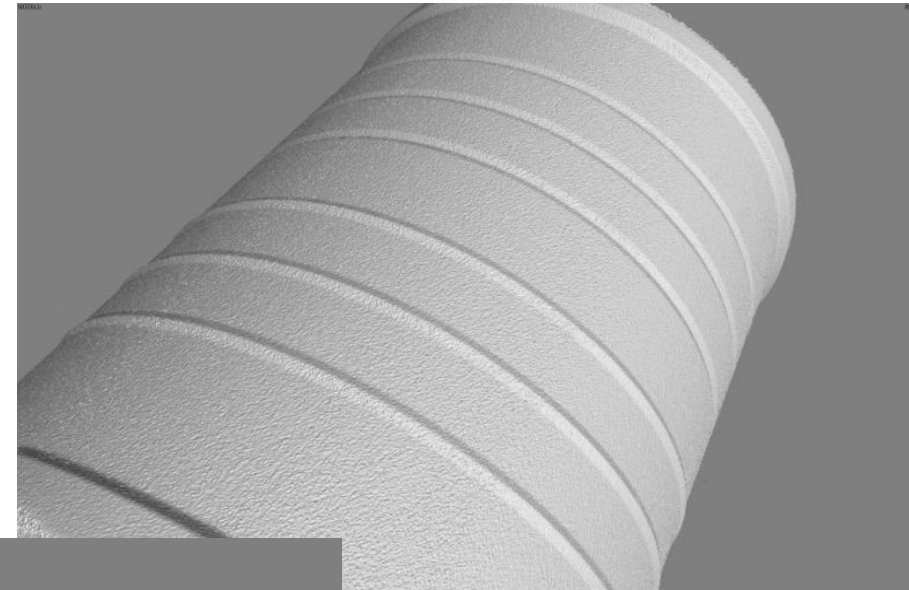


Application to CT



CT measurement using

- Nikon XT 255 ST
- VG Studio Max 2.2



Parameters:

$U = 150 \text{ kV}$

$P = 1.95 \text{ W}$

no filter

Mag. 120

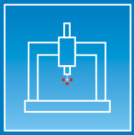
1.67 μm voxel size

1500 projections

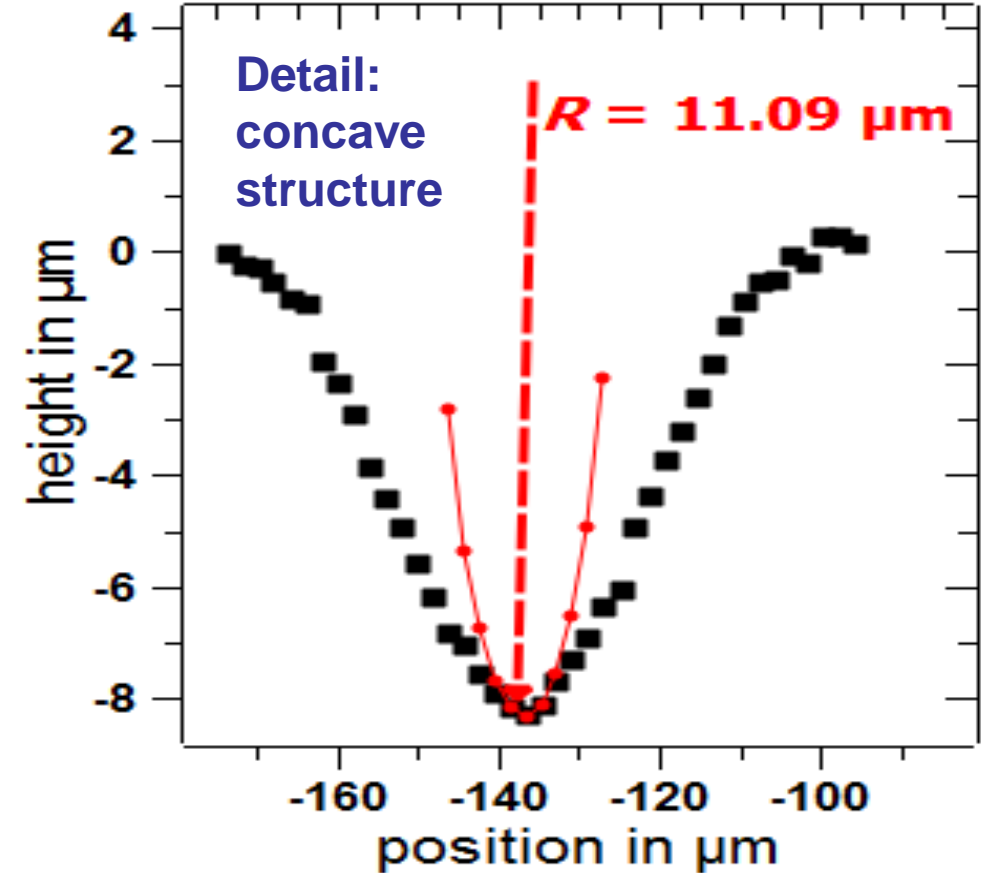
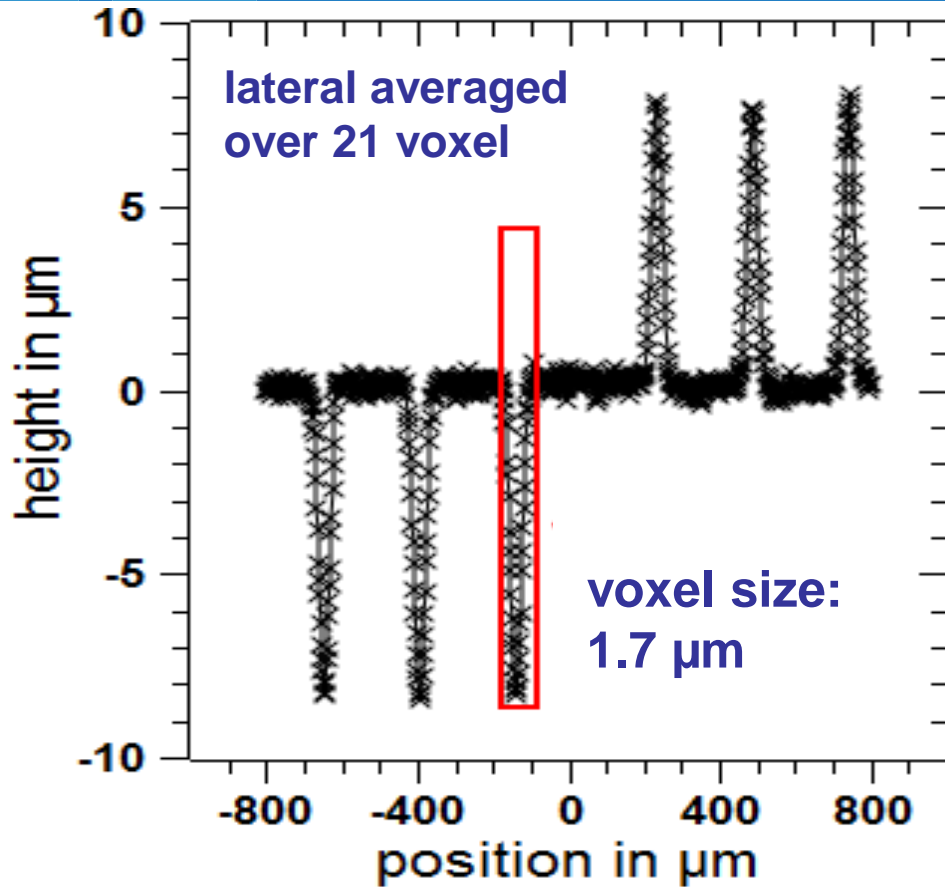
3h20 min measured

adaptive surface

determination



Reference standard



Calibration

data R azimuthal measurements median value

in μm		1	2	3	4	5	p_{20}	p_{50}	p_{80}	S
R1	6.72	6.27	8.19	9.46	11.09	14.48	7.23	9.46	12.78	4.22
R2	4.50	5.08	7.84	9.78	12.79	14.66	6.46	9.78	13.72	5.20

Result:

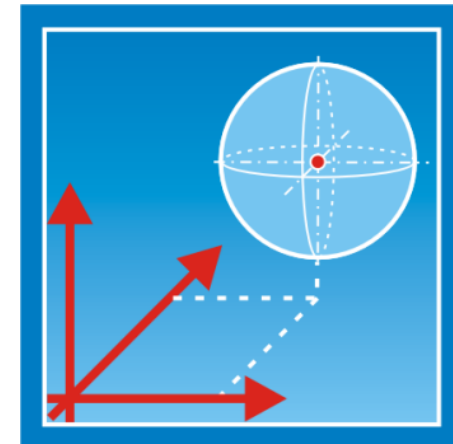
Structural resolution

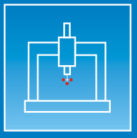
$S \approx 4,7 \mu\text{m}$

$\approx 2,35 \cdot \text{voxel size}$



- **Standardization of dimensional CT** started in 2004 in Germany (VDI/VDE 2630 series)
Today ISO TC 213 WG 10 is working on future ISO 10360-CT.
Due to the complexity of CT **open issues** exist — esp. for standardization:
Material influence, test design & data analysis and structural resolution for dimensional measurements
- Measurements and **a new standard design for hole plates** have been presented showing the ability to assess length measurement errors and material impact.
Bidirectional error statements appear still necessary for *E* testing of CT
- **Structural resolution testing** is a necessary add-on to tests of length measurement & probing errors. New approach has been presented which appears applicable also to CT.
Further work has to be done to create comparability to other sensors and to detail testing conditions as e.g. lateral averaging





Thank you for your attention!



The authors thank for their contribution:

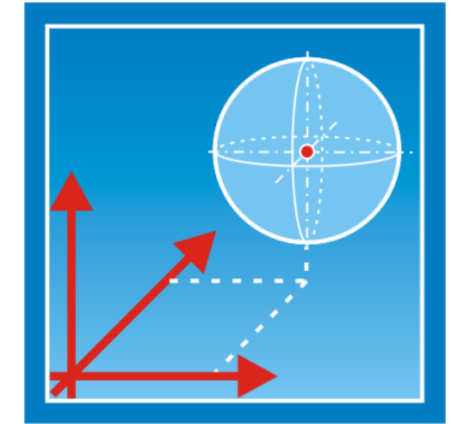
[Dr. I. Schmidt](#), Werth Messtechnik, Germany
for providing a calibrated hole plate

[S. Verhülsdonk](#), [Dr. R. Meeß](#), PTB, Germany
for manufacturing the new resolution standard

[T. Dziomba](#), PTB, Germany
for AFM measurements of the new resolution standard

[Dr. M. Krystek](#), PTB, Germany
for assistance with analytical solution of S

Contact:
markus.bartscher@ptb.de



Recent addendum:

We offer jobs to Early Stage Researchers (ESR) @ PTB:

EU Project INTERAQCT (see www.interaqct.eu)

(EU mobility criteria are of importance!

Total number of positions: 13 ESR + 2 ER)

